



Description

The IRFR024N-HXY uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

$V_{DS} = 100V$ $I_D = 20A$

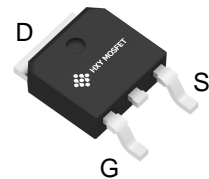
$R_{DS(ON)} < 87m\Omega$ @ $V_{GS}=10V$

Application

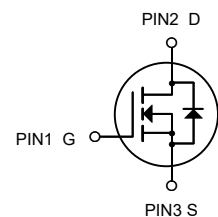
Battery protection

Load switch

Uninterruptible power supply



TO-252-2L
(TO-252-2(DPAK))



N-Channel MOSFET

Package Marking and Ordering Information

| Product ID | Pack | Marking | Qty(PCS) |
|--------------|---------------------------|----------------|----------|
| IRFR024N-HXY | TO-252-2L(TO-252-2(DPAK)) | 20N10 XXX YYYY | 2500 |

Absolute Maximum Ratings $T_C=25^{\circ}C$ unless otherwise noted

| Symbol | Parameter | Rating | Units |
|------------------------|---|------------|---------------|
| V_{DS} | Drain-Source Voltage | 100 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D@T_C=25^{\circ}C$ | Continuous Drain Current, V_{GS} @ 10V ¹ | 20 | A |
| $I_D@T_C=100^{\circ}C$ | Continuous Drain Current, V_{GS} @ 10V ¹ | 10 | A |
| $I_D@T_A=25^{\circ}C$ | Continuous Drain Current, V_{GS} @ 10V ¹ | 5 | A |
| $I_D@T_A=70^{\circ}C$ | Continuous Drain Current, V_{GS} @ 10V ¹ | 3.4 | A |
| I_{DM} | Pulsed Drain Current ² | 30 | A |
| EAS | Single Pulse Avalanche Energy ³ | 6.1 | mJ |
| I_{AS} | Avalanche Current | 15 | A |
| $P_D@T_C=25^{\circ}C$ | Total Power Dissipation ⁴ | 34.7 | W |
| $P_D@T_A=25^{\circ}C$ | Total Power Dissipation ⁴ | 2 | W |
| T_{STG} | Storage Temperature Range | -55 to 150 | $^{\circ}C$ |
| T_J | Operating Junction Temperature Range | -55 to 150 | $^{\circ}C$ |
| $R_{\theta JA}$ | Thermal Resistance Junction-ambient ¹ | 62 | $^{\circ}C/W$ |
| $R_{\theta JC}$ | Thermal Resistance Junction-Case ¹ | 3.6 | $^{\circ}C/W$ |



Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------------------------|--|--|------|-------|-----------|---------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0V$, $I_D=250\mu A$ | 100 | --- | --- | V |
| $\Delta BV_{DSS}/\Delta T$ | BVDSS Temperature Coefficient | Reference to 25°C , $I_D=1mA$ | --- | 0.098 | --- | $V/^\circ\text{C}$ |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance ² | $V_{GS}=10V$, $I_D=10A$ | --- | 80 | 87 | $m\Omega$ |
| | | $V_{GS}=4.5V$, $I_D=8A$ | --- | 95 | 105 | $m\Omega$ |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}$, $I_D=250\mu A$ | 1.0 | --- | 2.5 | V |
| $\Delta V_{GS(th)}$ | $V_{GS(th)}$ Temperature Coefficient | | --- | -4.57 | --- | $mV/^\circ\text{C}$ |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=80V$, $V_{GS}=0V$, $T_J=25^\circ\text{C}$ | --- | --- | 1 | μA |
| | | $V_{DS}=80V$, $V_{GS}=0V$, $T_J=55^\circ\text{C}$ | --- | --- | 5 | μA |
| I_{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm 20V$, $V_{DS}=0V$ | --- | --- | ± 100 | nA |
| g_{fs} | Forward Transconductance | $V_{DS}=5V$, $I_D=10A$ | --- | 13 | --- | S |
| R_g | Gate Resistance | $V_{DS}=0V$, $V_{GS}=0V$, $f=1MHz$ | --- | 2 | --- | Ω |
| Q_g | Total Gate Charge (10V) | $V_{DS}=80V$, $V_{GS}=10V$, $I_D=10A$ | --- | 26.2 | --- | nC |
| Q_{gs} | Gate-Source Charge | | --- | 4.6 | --- | |
| Q_{gd} | Gate-Drain Charge | | --- | 5.1 | --- | |
| $T_{d(on)}$ | Turn-On Delay Time | $V_{DD}=50V$, $V_{GS}=10V$, $R_G=3.3\Omega$ $I_D=10A$ | --- | 4.2 | --- | ns |
| T_r | Rise Time | | --- | 8.2 | --- | |
| $T_{d(off)}$ | Turn-Off Delay Time | | --- | 35.6 | --- | |
| T_f | Fall Time | | --- | 9.6 | --- | |
| C_{iss} | Input Capacitance | $V_{DS}=15V$, $V_{GS}=0V$, $f=1MHz$ | --- | 1535 | --- | pF |
| C_{oss} | Output Capacitance | | --- | 60 | --- | |
| C_{rss} | Reverse Transfer Capacitance | | --- | 37 | --- | |

Diode Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|--|---|------|------|------|------|
| I_S | Continuous Source Current ^{1,5} | $V_G=V_D=0V$, Force Current | --- | --- | 20 | A |
| I_{SM} | Pulsed Source Current ^{2,5} | | --- | --- | 30 | A |
| V_{SD} | Diode Forward Voltage ² | $V_{GS}=0V$, $I_S=1A$, $T_J=25^\circ\text{C}$ | --- | --- | 1.2 | V |
| t_{rr} | Reverse Recovery Time | $I_F=10A$, $dI/dt=100A/\mu s$, $T_J=25^\circ\text{C}$ | --- | 37 | --- | nS |
| Q_{rr} | Reverse Recovery Charge | | --- | 27.3 | --- | nC |

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 20Z copper.
2. The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating. The test condition is $V_{DD}=25V$, $V_{GS}=10V$, $L=0.1mH$, $I_{AS}=11A$
4. The power dissipation is limited by 150°C junction temperature
5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

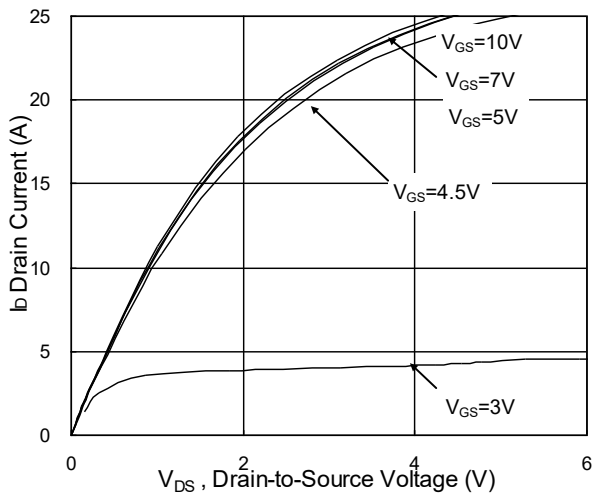


Fig.1 Typical Output Characteristics

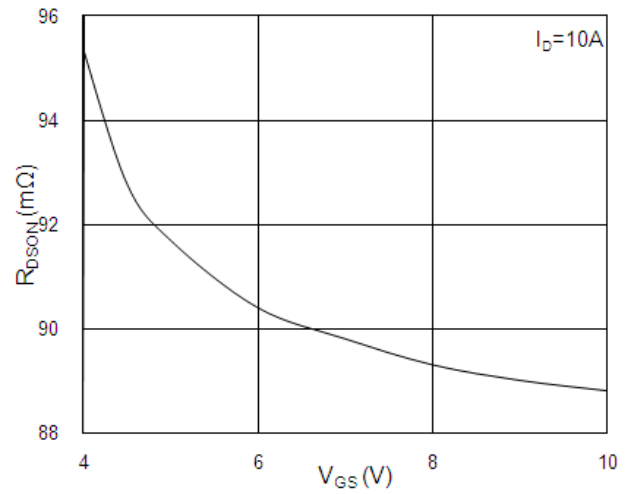


Fig.2 On-Resistance vs. Gate-Source

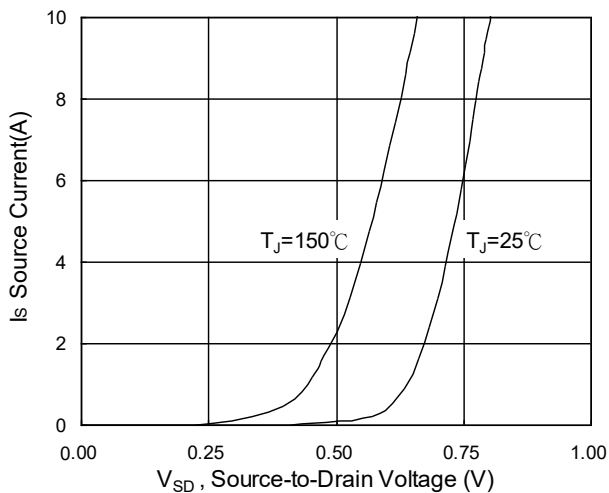


Fig.3 Forward Characteristics Of Reverse

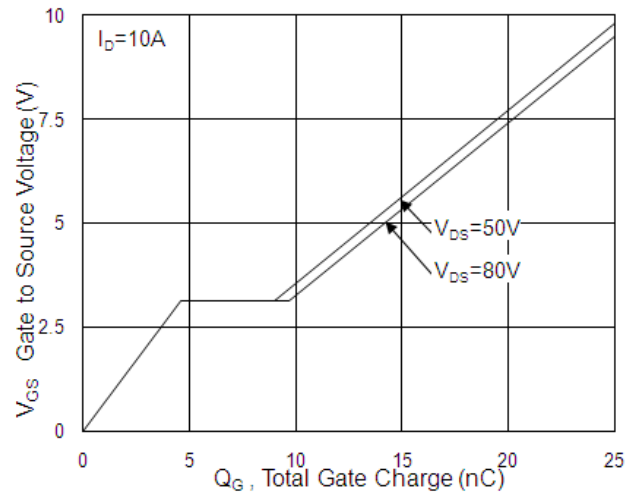


Fig.4 Gate-Charge Characteristics

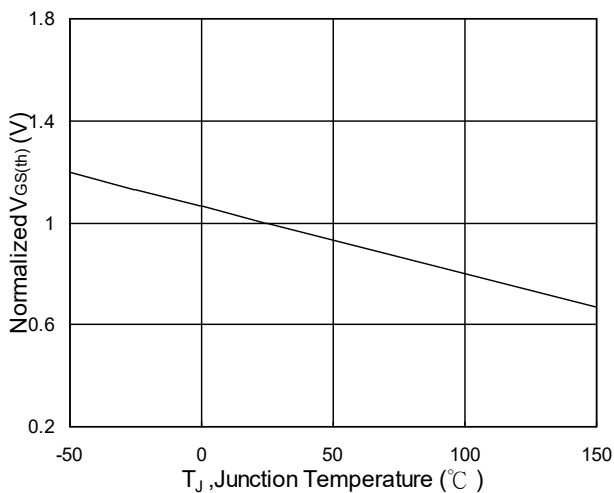


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

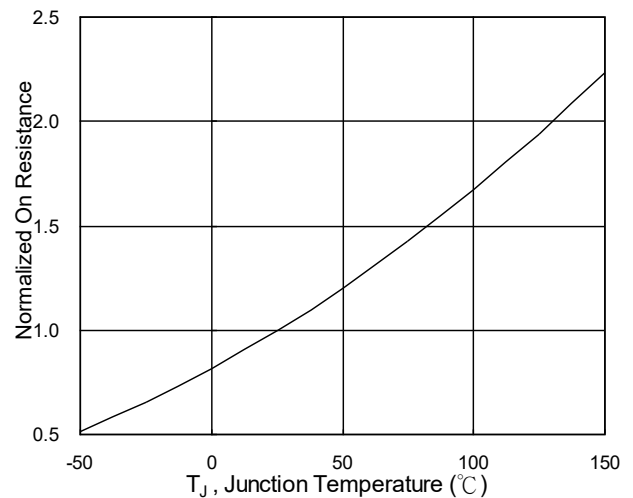


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

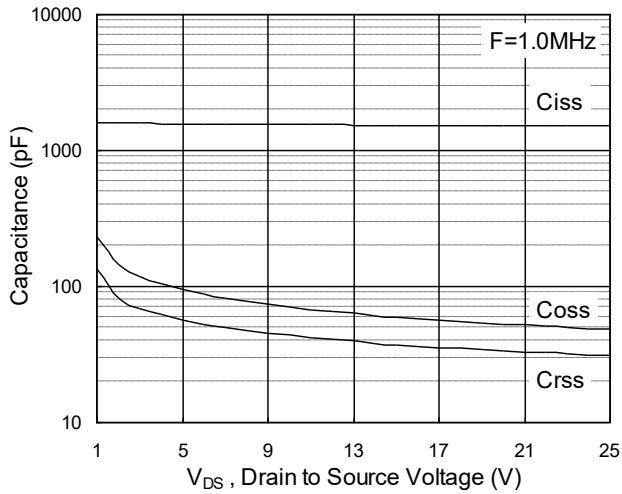


Fig.7 Capacitance

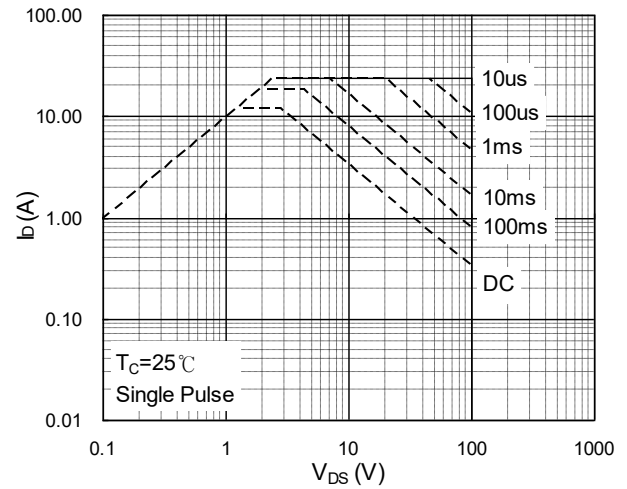


Fig.8 Safe Operating Area

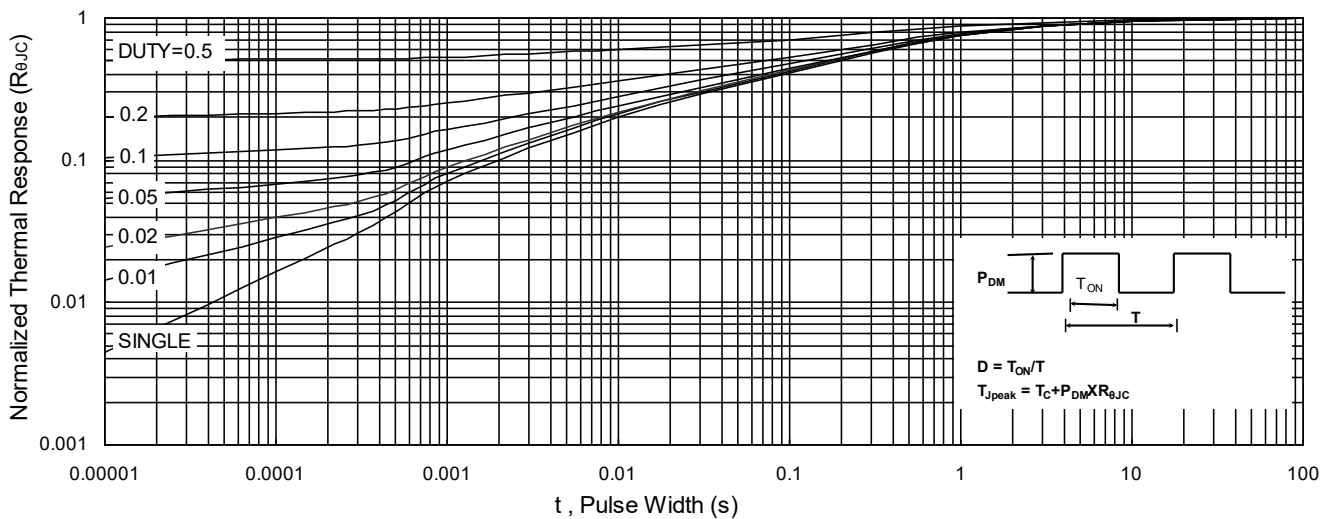


Fig.9 Normalized Maximum Transient Thermal Impedance

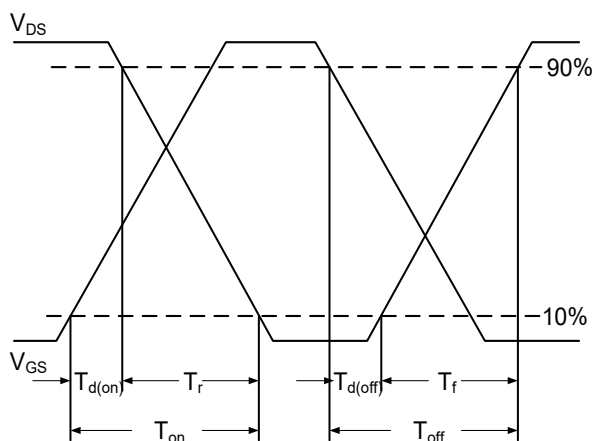


Fig.10 Switching Time Waveform

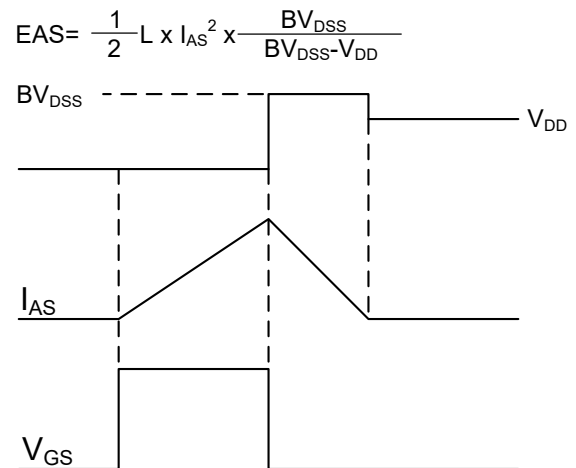
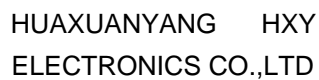


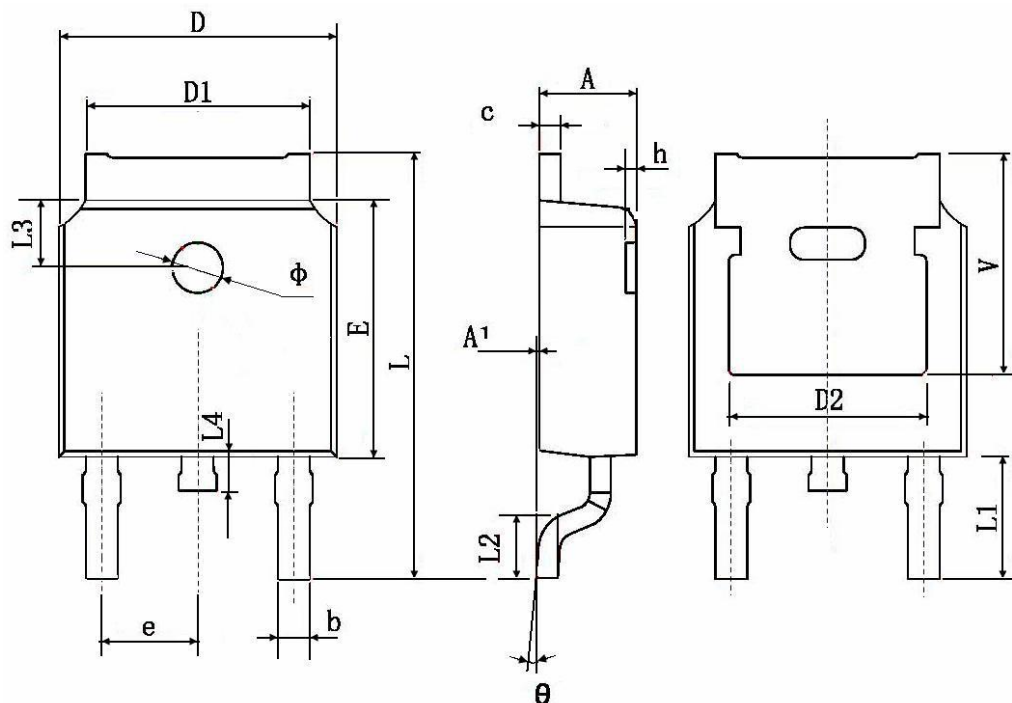
Fig.11 Unclamped Inductive Switching Waveform



IRFR024N-HXY

N-Channel Enhancement Mode MOSFET

TO-252-2L(TO-252-2(DPAK)) Package Information



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|--------|----------------------|-------|
| | Min. | Max. | Min. | Max. |
| A | 2.200 | 2.400 | 0.087 | 0.094 |
| A1 | 0.000 | 0.127 | 0.000 | 0.005 |
| b | 0.660 | 0.860 | 0.026 | 0.034 |
| c | 0.460 | 0.580 | 0.018 | 0.023 |
| D | 6.500 | 6.700 | 0.256 | 0.264 |
| D1 | 5.100 | 5.460 | 0.201 | 0.215 |
| D2 | 0.483 TYP. | | 0.190 TYP. | |
| E | 6.000 | 6.200 | 0.236 | 0.244 |
| e | 2.186 | 2.386 | 0.086 | 0.094 |
| L | 9.800 | 10.400 | 0.386 | 0.409 |
| L1 | 2.900 TYP. | | 0.114 TYP. | |
| L2 | 1.400 | 1.700 | 0.055 | 0.067 |
| L3 | 1.600 TYP. | | 0.063 TYP. | |
| L4 | 0.600 | 1.000 | 0.024 | 0.039 |
| Φ | 1.100 | 1.300 | 0.043 | 0.051 |
| θ | 0° | 8° | 0° | 8° |
| h | 0.000 | 0.300 | 0.000 | 0.012 |
| V | 5.350 TYP. | | 0.211 TYP. | |



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